

UNBELIEVABLY POWERFUL. INSANELY EASY.



WaveRunner 8000 500 MHz – 4 GHz Oscilloscopes

Superior User Experience

Powerful, Deep Toolbox

Exceptional Serial Data Tools

"M" Models for Maximum Sample Rate and Memory The WaveRunner 8000 combines a superior oscilloscope experience with an extensive toolbox to deliver faster time to insight.



UNBELIEVABLY POWERFUL. INSANELY EASY.

WaveRunner 8000



Designed for Touch

Built for Simplicity

Made to Solve





The WaveRunner 8000 combines a superior oscilloscope experience with an extensive toolbox to deliver faster time to insight.

- 1 Superior User Experience
- 2 Powerful, Deep Toolbox
- 3 Exceptional Serial Data Tools
- "M" Models for Maximum Sample Rate and Memory



Faster Time to Insight

Insight alone is not enough.

Markets and technologies change too rapidly.

The **timing** of **critical design**

decisions is significant.

Time to insight is what matters.



MAUI - SUPERIOR USER EXPERIENCE



MAUI – Most Advanced User Interface was developed to put all the power and capabilities of the modern oscilloscope right at your fingertips. Designed for touch; all important oscilloscope controls are accessed through the intuitive touch screen. Built for simplicity; time saving shortcuts and intuitive dialogs simplify setup. Made to solve; a deep set of debug and analysis tools helps identify problems and find solutions quickly.

Designed for Touch

MAUI is designed for touch. Operate the oscilloscope just like a phone or tablet with the most unique touch screen features on any oscilloscope. All important controls are always one touch away. Touch the waveform to position or zoom in for more details using intuitive actions.

Built for Simplicity

MAUI is built for simplicity. Basic waveform viewing and measurement tools as well as advanced math and analysis capabilities are seamlessly integrated in a single user interface. Time saving shortcuts and intuitive dialogs simplify setup and shorten debug time.

Made to Solve

MAUI is made to solve. A deep set of integrated debug and analysis tools help identify problems and find solutions quickly. Unsurpassed integration provides critical flexibility when debugging. Solve problems fast with powerful analysis tools.

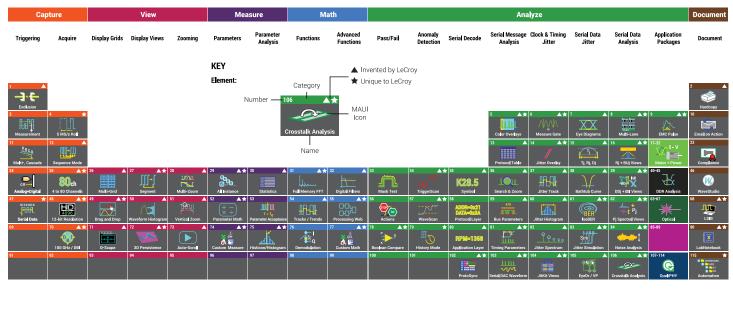
MAUI with OneTouch

MAUI with OneTouch introduces a new paradigm for oscilloscope user experience. Dramatically reduce setup time with revolutionary drag and drop actions to copy and setup channels, math functions, and measurement parameters without lifting a finger. Use common gestures like drag, drop, and flick to instinctively interact with the oscilloscope. Quickly enable a new channel, math or measurement using the "Add New" button and simply turn off any trace or parameter with a flick of the finger. These OneTouch innovations provide unsurpassed efficiency in oscilloscope operation.



- Channel, timebase, and trigger descriptors provide easy access to controls without navigating menus.
- Configure parameters by touching measurement results.
- Shortcuts to commonly used functions are displayed at the bottom of the channel, math and memory menus.
- Use the "Add New" button for one-touch trace creation.
- Drag to change source, copy setup, turn on new trace, or move waveform location.
- Drag to copy measurement parameters to streamline setup process.
- G Drag to quickly position cursors on a trace.

POWERFUL, DEEP TOOLBOX





Our Heritage

Teledyne LeCroy's 50+ year heritage has its origins in the high-speed collection of data in the field of high-energy physics, and the processing of long records to extract meaningful insight. We didn't invent the oscilloscope, but we did invent the digital oscilloscope, which can take full advantage of advanced digital signal processing and waveshape analysis tools to provide unparalleled insight.

Our Obsession

Our developers are true to our heritage — they are more obsessed with making better and smarter tools than anybody else. Our tools and operating philosophy are standardized across much of our product line for a consistent user experience. Our mission is to help you use these tools to understand problems, including the ones you don't even know you have. Our deep toolbox inspires insight; and your moment of insight is our reward.

Our Invitation

Our Periodic Table of Oscilloscope
Tools provides a framework to
understand the toolsets that Teledyne
LeCroy has created and deployed in
our oscilloscopes. Visit our interactive
website to learn more about what we
offer and how we can help you develop
and debug more efficiently.

teledynelecroy.com/tools

WAVERUNNER 8000 AT A GLANCE

The WaveRunner 8000 combines a superior oscilloscope experience with an extensive toolbox to shorten debug time. MAUI with OneTouch includes the most unique touch features on any oscilloscope providing unsurpassed efficiency in oscilloscope operation. Offering 500 MHz - 4 GHz of bandwidth, 40 GS/s sample rate, long memory, MAUI — Most Advanced User Interface, and a versatile toolset make the WaveRunner 8000 unbelievably powerful and insanely easy to use.

Key Features

500 MHz - 4 GHz bandwidths

Up to 40 GS/s sample rate

MAUI with OneTouch

- Designed for touch
- Built for simplicity
- Made to solve

Advanced Tools

- Jitter and Timing Analysis Capabilities
- WaveScan Search and Find
- LabNotebook Documentation and Report Generation
- History Mode Waveform Playback

Optional Software Packages

- Advanced Customization
- Digital Filtering
- Spectrum Analysis
- Device and Switching Power Supply Analysis
- Comprehensive set of serial data analysis, debug, validation and compliance tools

16 digital channels with 1.25 GS/s

- Analog and Digital Cross-Pattern Triggering
- Digital Pattern Search and Find
- Analog and Digital Timing Measurements
- Logic Gate Emulation
- Activity Indicators



Superior User Experience

The WaveRunner 8000 with MAUI
OneTouch sets the standard for
oscilloscope user experience by
providing the most unique touch
features on any oscilloscope. Common
gestures are used to instinctively interact
with the oscilloscope and dramatically
reduce setup time. Convenience and
efficiency are optimized - all common
operations can be performed with one
touch and do not require opening and
closing of pop-up dialogs or menus.

Exceptional Serial Data Tools

A wide a variety of application packages are available to meet all serial data test challenges, ranging from automated compliance packages to flexible debug toolkits. A suite of protocol specific measurement and eye diagram packages are available to complement the industry's most intuitive trigger and decode packages.

Powerful, Deep Toolbox

The standard collection of math, measurement, debug, and documentation tools provides unsurpassed analysis capabilities. Application-specific packages enable streamlined debugging for common design/validation scenarios. The advanced customization option (XDEV) enables user-defined parameters and math functions providing unique and limitless analysis capability.

"M" Models for Maximum Sample Rate and Memory

An industry leading 40 GS/s sample rate allows for a detailed edge reconstruction even for signals with the fastest rise times. Long memory allows for maximum sample rate to be maintained in longer timebases. Deep memory of 128 Mpts is ideal for debugging long term behavior on high speed serial data buses.



Key Attributes

- 1. 12.1" Widescreen (16 x 9) high resolution WXGA color touch screen display
- 2. MAUI with OneTouch optimized for convenience and efficiency
- **3.** "Add New" button for fast waveform creation
- **4.** Serial trigger captures signals up to 3 Gb/s
- "Push" Knobs All knobs have push functionality that provide shortcuts to common actions such as Set to Variable, Find Trigger Level, Zero Offset, and Zero Delay

- 6. Waveform Control Knobs –
 Control channel, zoom, math
 and memory traces with the
 multiplexed vertical and
 horizontal knobs
- Dedicated Cursor Knob –
 Select type of cursor, position
 them on your signal, and read
 values without ever opening
 Ava menu
- **8.** Dedicated buttons to quickly access popular debug tools.
- Mixed Signal Capability Debug complex embedded designs with integrated 16 channel mixed signal capability

- **10.** Reference Clock Input/Output connectors for connecting to other equipment
- **11.** Easy connectivity with four USB 3.1 ports and three USB 2.0 ports
- **12.** USBTMC (Test and Measurement Class) over USB 3.1 for fast data offload

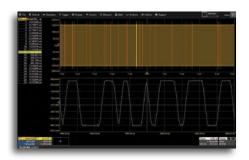


ADVANCED TOOLS FOR WAVEFORM ANALYSIS

Serial Trigger, Decode, Measure/Graph, and Eye Diagrams

Isolate events using the serial bus trigger and view color-coded protocol information on top of analog or digital waveforms. Timing and bus measurements allow quick and easy characterization of a serial data system. Serial (digital) data can be extracted and graphed to monitor system performance over time. Identify physical layer anomalies with eye diagram mask testing and mask failure locator.





WaveScan Advanced Search and Find Tool

Quickly scan analog, digital or parallel bus signals for runts, glitches or other anomalies with WaveScan.



Jitter and Timing Analysis

Understand system jitter performance of clock and data signals.
Enable histograms, tracks, and spectrum plots to visualize the data.



Spectrum Analyzer Mode

View signal details in the frequency domain with a spectrum analyzer style user interface.

Sequence Mode Acquisition

Capture many fast pulses in quick succession or events separated by long periods of time.

History Mode Waveform Playback

Scroll back in time to isolate anomalies that have previously been captured to quickly find the source of the problem.

LabNotebook Documentation and Report Generation Tool

Save all results and data with a single button press and create custom reports with LabNotebook.

POWERFUL MIXED SIGNAL CAPABILITIES

Teledyne LeCroy's WaveRunner 8000-MS mixed signal oscilloscope combines the high-performance analog channels of the WaveRunner 8000 with the flexibility of 16 digital inputs. In addition, the many triggering and decoding options turn the WaveRunner 8000-MS into an all-in-one analog, digital, serial debug machine.

High-performance 16-Channel Mixed Signal Capability

With embedded systems growing more complex, powerful mixed signal debug capabilities are an essential part of modern oscilloscopes. The 16 integrated digital channels and set of tools designed to view, measure and analyze analog and digital signals enable fast debugging of mixed signal designs.

Advanced Digital Debug Tools

Using the powerful parallel pattern search capability of WaveScan, patterns across many digital lines can be isolated and analyzed. Identified patterns are presented in a table with timestamp information and enables quick searching for each pattern occurrence.

Use a variety of the many timing parameters to measure and analyze the characteristics of digital busses. Powerful tools like tracks, trends, statistics and histicons provide additional insight and help find anomalies.

Quickly see the state of all the digital lines at the same time using convenient activity indicators.

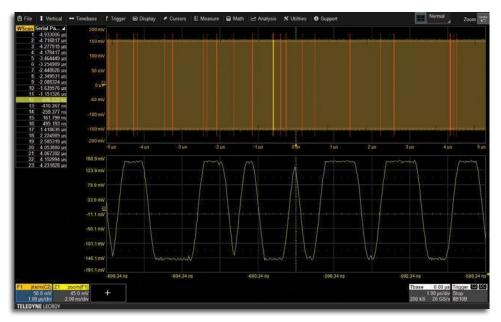
Simulate complete digital designs using logic gate emulation. When used with the web editor, many logic gates can be combined together in one math function to simulate complex logic designs. Choose from AND, OR, NAND, NOR, XOR, NOT and D Flip Flop gates.

Extensive Triggering

Flexible analog and digital cross-pattern triggering across all 20 channels provides the ability to quickly identify and isolate problems in an embedded system. Event triggering can be configured to arm on an analog signal and trigger on a digital pattern.



STANDARD TOOLS FOR ADVANCED ANALYSIS



WaveScan Advanced Search

WaveScan provides powerful isolation capabilities that hardware triggers can't provide. WaveScan allows searching analog, digital or parallel bus signal in a single acquisition using more than 20 different criteria. Or, set up a scan condition and scan for an event over hours or even days.

Since the scanning "modes" are not simply copies of the hardware triggers, the utility and capability is much higher. For instance, there is no "frequency" trigger in any oscilloscope, yet WaveScan allows for "frequency" to be quickly "scanned." This allows the user to accumulate a data set of unusual events that are separated by hours or days, enabling faster debugging.

When used in multiple acquisitions,
WaveScan builds on the traditional
Teledyne LeCroy strength of fast
processing of data. Quickly scan
millions of events looking for unusual
occurrences, and do it much faster and

more efficiently than other oscilloscopes can. Found events can be overlaid with the ScanOverlay to provide a quick comparison of events; measurement based scans populate the ScanHistogram to show the statistical distribution of the events.

Additionally, digital lines can be used as inputs into WaveScan to isolate and analyze patterns using the powerful parallel pattern search capability. Identified patterns are presented in a table with timestamp information and enables quick searching for each pattern occurrence.

Advanced Waveform Capture with Sequence Mode

Use Sequence mode to store up to 15,000 triggered events as "segments" into memory. This can be ideal when capturing many fast pulses in quick succession or when capturing events separated by long time periods.

Sequence mode provides timestamps for each acquisition and minimizes dead-time between triggers to less than 1 µs. Combine Sequence mode with advanced triggers to isolate rare events over time and analyze afterwards.

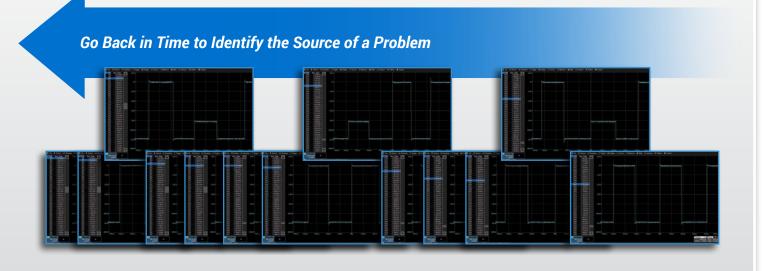
Advanced Math and Measure

With many math functions and measurement parameters available, the WaveRunner 8000 can measure and analyze every aspect of analog and digital waveforms. Beyond just measuring waveforms, the WaveRunner 8000 provides statistics, histicons, tracks and trends to show how waveforms change over time. Measurements and math functions can be quickly copy and setup using MAUI with OneTouch.



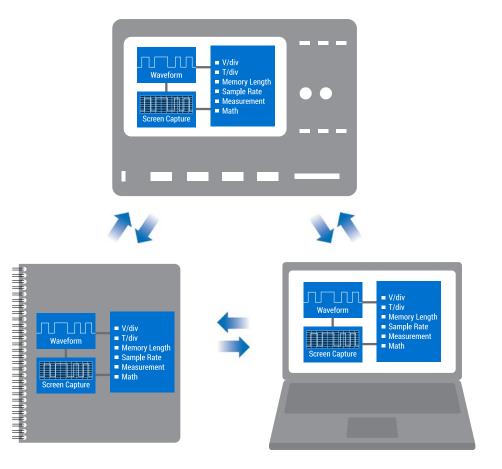
History Mode Waveform Playback

Scroll back in time using History Mode to view previous waveforms and isolate anomalies. Use cursors and measurement parameters to quickly find the source of problems. History mode is always available with a single button press, no need to enable this mode and never miss a waveform.



LabNotebook

The LabNotebook feature of WaveRunner 8000 is the ideal documentation tool. LabNotebook automatically saves all displayed waveforms, oscilloscope setup file, and a screen with a single button press, eliminating the need to navigate multiple menus to save all these files independently. Report files can be annotated and shared with colleagues to fully document all results. Easily recreate experiments and compare tests results amongst colleagues across the world by recalling LabNotebook files back onto the oscilloscope or view on a PC using WaveStudio.



MOST COMPLETE SERIAL DATA DEBUG AND VALIDATION

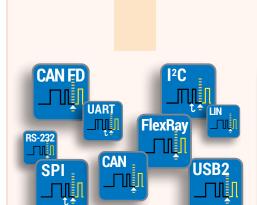
The WaveRunner 8000 features the widest range and most complete serial data debug and validation solutions.

- Triggering
- Decoding
- Measurement and Graphing
- Eye Diagram and Physical Layer Analysis

Various compliance test, synchronized protocol decode views, and other advanced jitter analysis tools are also available.

Solutions address the following markets and applications:

- Embedded Computing
- Automotive
- Industrial
- Military and Avionics
- Peripherals
- Memory
- Handset/Mobile/Cellular
- High Speed Computing
- Data Storage
- Serial Digital Audio



Trigger

Powerful, flexible triggers designed by people who know the standards, with the unique capabilities you want to isolate unusual events. Conditional data triggering permits maximum flexibility and highly adaptable error frame triggering is available to isolate error conditions. Frame definition allows grouping of UART or SPI packets into message frames for customization.





Decode

Decoded protocol information is color-coded to specific portions of the serial data waveform and transparently overlaid for an intuitive, easy-to-understand visual record. All decoded protocols are displayed in a single time-interleaved table. Touch a row in the interactive table to quickly zoom to a packet of interest and easily search through long records for specific protocol events using the built-in search feature.

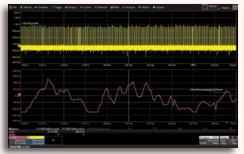


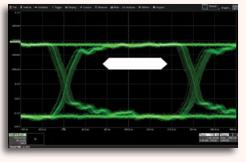
ProtoSync

ProtoSync combines the oscilloscope view with a simultaneous view of data link layer decodes on the same instrument. This combination makes ProtoSync very effective in debugging protocol-specific negotiation rates.

Compatible with PCI Express, USB 2.0, USB2-HSIC, SAS, SATA, and Fibre Channel.







Measure/Graph

Quickly validate cause and effect with automated timing measurements to or from an analog signal or another serial message. Make multiple measurements in a single long acquisition to quickly acquire statistics during cornercase testing. Serial (digital) data can be extracted to an analog value and graphed to monitor system performance over time, as if it was probed directly. Complete validation faster and gain better insight.

Eye Diagram

Rapidly display an eye diagram of your packetized low-speed serial data signal without additional setup time. Use eye parameters to quantify system performance and apply a standard or custom mask to identify anomalies. Mask failures can be indicated and can force the scope into Stop mode.

SDAII or DDR Debug (optional) create eye diagrams of streaming NRZ serial data or DDR signals, and measure and analyze jitter breakdown.

QualiPHY / Compliance

Compliance testing is a critical part of the design cycle in order to ensure that requirements are met. The QualiPHY framework provides an automated and easy-to-use compliance testing platform for a number of serial data standards.



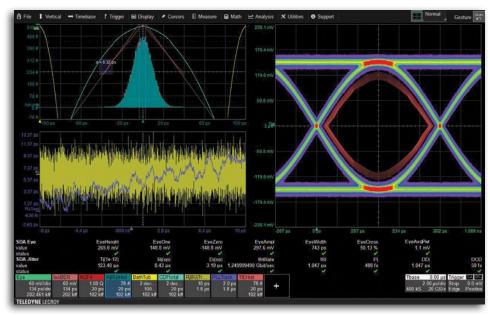


	WaveRunner 8000 Serial Data Protocol Support	Trigger	Decode	Measure/Grant	Eye Diagram	Protosync	QualipHy
- D	I ² C	•	•	•	•		
Embedded Computing	SPI	•	•	•	•		
Somp	UART-RS232	•	•	•	•		
	USB2-HSIC		•				
	CAN	•	•	•	•		
strial	CAN FD	•	•	•	•		
Indus	FlexRay	•	•	•	•		
- + -	LIN	•	•	•	•		
moti	SENT		•				
Automotive + Industrial	MOST50/150						•
	BroadR-Reach						•
γ	ARINC429		•	•	•		
Avionics	MIL-STD-1553	•	•	•	•		
Ā	SPACEWIRE		•				
	Ethernet (10/100Base-T)		•				•
ting, als	Ethernet (1000Base-T)						•
mbu	USB 2.0	•	•	•	•	•	•
d Co	8b/10b	•	•		•		
Spee age -	Fibre Channel		•				
High Speed Computing Storage +Peripherals	SATA (1.5 & 3 Gb/s)	•	•			•	
	SAS (1.5 & 3 Gb/s)		•			•	
	PCI Express (Gen1)		•			•	
2	LPDDR2				•		•
Memory	DDR2				•		•
Σ	DDR3				•		•
ĺ	D-PHY/CSI-2/DSI		•		•		•
Ì	DigRF3G		•	•			
MIPI	DigRFv4		•	•			
	UniPro		•				
	M-PHY		•		•		
	Audio (I ² S, LJ, RJ, TDM)	•	•	•			
Other	Manchester		•				
	NRZ	•	•		•		
		_					

MOST COMPLETE SERIAL DATA DEBUG AND VALIDATION

SDA II – Advanced Tools to Isolate and Analyze (WR8K-SDAII)

Unleash the power of serial data analysis for understanding and characterizing a design, proving compliance, and understanding why a device or host fails compliance. The SDAII architecture provides fast updates and eye diagram creation. Combined with up to 128 Mpts record lengths and more complete jitter decomposition tools, SDA II provides a fast and complete understanding of why serial data fails a compliance test. Whether debugging eye pattern or other compliance test failures, the WaveRunner 8000 Oscilloscopes rapidly isolate the source of the problem.



Advanced jitter decomposition methodologies and tools provide more information about root cause. Tj
Analysis, RjBUj Analysis and DDj

Analysis are made simple with the deepest toolset dedicated to providing the highest level of insight into your serial data signals.

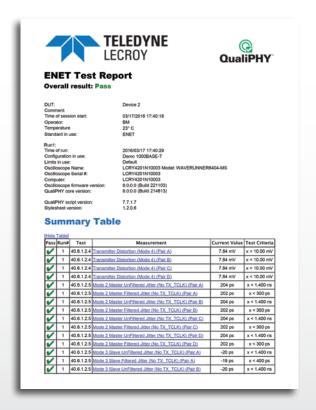
QualiPHY

QualiPHY is designed to reduce the time, effort, and specialized knowledge needed to perform compliance testing on high-speed serial buses.

- Guides the user through each test setup
- Performs each measurement in accordance with the relevant test procedure
- Compares each measured value with the applicable specification limits
- Fully documents all results
- QualiPHY helps the user perform testing the right way every time

Supported Standards:

- ENET
- USB
- DDR2, DDR3, LPDDR2
- MIPI-DPHY
- BroadR-Reach
- MOST50, MOST150



Compliance Reports contain all of the tested values, the specific test limits and screen captures. Compliance Reports can be created as HTML, PDF or XML.



Jitter and Timing Analysis Option (WR8K-JITKIT)

JITKIT makes it simple and easy to understand the basic system jitter performance of clock signals and clock-data activities, including period, half period, cycle-cycle, skew, amplitude, differential voltage crossing, slew rate, and a wide variety of other common jitter measurements.



DDR Debug Toolkit (WR8K-DDR3-Toolkit)

The DDR Debug Toolkit provides test, debug and analysis tools for the entire DDR design cycle. The unique DDR analysis capabilities provide automatic Read and Write burst separation, bursted data jitter analysis and DDR-specific measurement parameters. The WaveRunner 8000 supports both standard and custom speed grades of DDR2 and DDR3.

Advanced Probe Interface

The advanced active probe interface gives tremendous flexibility for measuring high voltages, high frequencies, currents, or differential signals.

High Impedance Active Probes



High Bandwidth Differential Probes



High Voltage Differential Probes



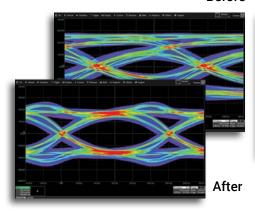
High Voltage Passive Probes



Current Probes



Before



Eye Doctor II (WR8K-EYEDRII)

The Eye Doctor II advanced signal integrity toolkit enables a complete set of channel emulation, de-embedding, and receiver equalization simulation tools. It provides capability to emulate a serial data link, de-embed or embed a fixture, cable or serial data channel, add or remove emphasis, and perform CTLE, FFE, or DFE equalization.



Q-Scape Multi-tab Display Architecture (WR8K-Q-SCAPE)

Unique Q-Scape multitab display architecture speeds up your understanding of your design with 4x the display area. Acquired or calculated waveforms can be located on any of four different "tabbed" oscilloscope grid displays, with individually selectable grid styles available for each tab. Quickly move waveforms to different tabs through drag-and-drop.

ADDITIONAL APPLICATIONS AND CUSTOMIZATION



Use two independent input settings and frequency ranges for advanced spectrum analysis.

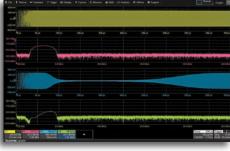
Spectrum Analyzer Option (WR8K-SPECTRUM)

The Spectrum Analyzer mode provides a spectrum analyzer style user interface with controls for start/stop frequency or center frequency and span. The resolution bandwidth is automatically set for best analysis or can be manually selected. Vertical Scale can be selected in the desired units and the unique peak search automatically labels spectral components and presents frequency and level in an interactive table. To monitor how the spectrum changes over time, view the spectrogram which can display a 2D or 3D history of the frequency content.



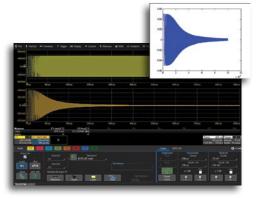
Power Analyzer Software Option (WR8K-PWR)

Quickly measure and analyze operating characteristics of power conversion circuits. Make automatic switching device measurements and identify areas of loss and conduction with color-coded overlay. Control loop modulation analysis and line power harmonic testing are all simplified with a dedicated user interface.



Digital Filter Software Option (WR8K-DFP2)

DFP2 lets you implement Finite
Impulse Response (FIR) or Infinite
Impulse Response (IIR) filters to eliminate undesired spectral components, such as noise, and enhances your ability to examine important signal components. You can choose from a standard set of FIR or IIR filters or you can also design your own custom filters. Create and apply a variety of FIR and IIR digital filters to your capture waveforms or processed traces.



XDEV Advanced Customization Option (WR8K-XDEV)

With the XDEV option, third party programs can be completely integrated into the oscilloscope's processing stream. Create customized math functions and parameters using C/C++, MATLAB, Excel, JScript or Visual Basic without ever leaving the oscilloscope application - and view the results directly on the oscilloscope, in real-time.

	WaveRunner 8054	WaveRunner 8104	WaveRunner 8254/ 8254M	WaveRunner 8404/ 8404M
Vertical System Analog Bandwidth @ 50 Ω (-3 dB)	500 MHz	1 GHz	2.5 GHz	4 GHz
	(≥ 2 mV/div)	(≥ 2 mV/div)	(≥ 5 mV/div)	(≥ 5 mV/div)
Analog Bandwidth @ 1 MΩ (-3 dB)	500 MHz (typical)	500 MHz (typical)	500 MHz (typical)	500 MHz (typical)
Rise Time (10–90%, 50 Ω)	700 ps (typical)	415 ps (typical)	160 ps (typical)	100 ps (typical)
Rise Time (20-80%, 50 Ω)	480 ps (typical)	290 ps (typical)	120 ps (typical)	75 ps (typical)
Input Channels	4			121
Bandwidth Limiters	20 MHz, 200 MHz	20 MHz, 200 MHz	20 MHz, 200 MHz, 1 GHz	20 MHz, 200 MHz, 1 GHz
Input Impedance Input Coupling	50 Ω ±2% or 1 MΩ 17pF, 10 1 MΩ: AC, DC, GND; 50 Ω: D0		Probe	
Maximum Input Voltage	50 Ω: 5 V _{rms} ±10 V peak; 1 M		< 10 kHz)	
Channel-Channel Isolation		ited BW (typical)	DC -2.5 GHz: >100:1; 2.5 GH	z to rated BW: >30:1 (typica
Vertical Resolution	8-bits; up to 11-bits with enh			
Sensitivity DC Vertical Gain Accuracy (Gain Component of DC Accuracy) Offset Range	50 Ω: 1 mV/div−1 V/div, fully ±1% F.S. (typical), offset at 0	v variable; 1 M Ω: 1 mV/div-10 V) Ω:
Unset Range	+1 6 V @ 1 mV – 4 95 mV/d	iv, ±4 V @ 5 mV-9.9 mV/div,		Σ: ≤ 1 GHz
	±8 V @ 10 mV-19.8 mV/d	liv, ±10 V @ 20 mV−1 V/div M Ω:	±1.6 V @ 1 mV-4.95 mV/d ±8 V @ 10 mV-19.8 mV/d	iv, ±4 V @ 5 mV–9.9 mV/div, div, ±10 V @ 20 mV–1 V/div
	±8 V @ 10 mV-19.8 mV/div, ±80 V @ 102 mV-1.0 V/div	iv, ±4 V @ 5 mV-9.9 mV/div, ±16 V @ 20 mV-100 mV/div , ±160 V @ 1.02 V-10 V/div	±1.4 V @ 5 mV-100 mV/d	• 1 GHz iv, ±10 V @ 102 mV-1 V/div
		, =	±1.6 V @ 1 mV-4.95 mV/d ±8 V @ 10 mV-19.8 mV/div,	ΜΩ: iv, ±4 V @ 5 mV-9.9 mV/div, ±16 V @ 20 mV-140 mV/di v, ±160 V @ 1.42 V-10 V/div
DC Vertical Offset Accuracy	±(1.5% of offset setting +1%	of full scale + 1 mV) (test lim		7, ±100 V (<u>@ 1.42 V 10 V/div</u>
Horizontal System				
Timebases	Internal timebase common t	o 4 input channels; an extern	al clock may be applied at the	EXT input
Time/Division Range	20 ps/div - 1.6 ks/div with st M Models: 20 ps/div - 6.4 ks RIS available at ≤ 10 ns/div; Roll Mode available at ≥ 100	andard memory s/div with standard memory		
Clock Accuracy	≤ 1.5 ppm +(aging of 0.5 ppn			
Trigger and Interpolator Jitter	≤ 4 ps _{rms} (typical) < 0.1 ps _{rms} (typical, software assisted)	≤ 3.5 ps _{rms} (typical) < 0.1 ps _{rms} (typical, software assisted)	≤ 2.5 ps _{rms} (typical) < 0.1 ps _{rms} (typical, software assisted)	≤ 2 ps _{rms} (typical) < 0.1 ps _{rms} (typical, software assisted
Channel-Channel Deskew Range	±9 x time/div. setting, each c	hannel		
External Timebase Reference (Input) External Timebase Reference (Output) External Clock	10 MHz ±25 ppm 10 MHz 3.5 dBm ±1 dBm, sy DC to 100 MHz; (50 Ω/1 MΩ Minimum rise time and amp), Ext. BNC input,	-	ernal reference)
Acquisition System				
Single-Shot Sample Rate/Ch	10 GS/s on 4 Ch	; 20 GS/s on 2 Ch		; 20 GS/s on 2 Ch n 4 Ch; 40 GS/s on 2 Ch
Random Interleaved Sampling (RIS) Maximum Trigger Rate	200 GS/s for repetitive signa 1,000,000 waveforms/secon		4 channels)	
Intersegment Time	1 µs	, 1141 mode, up to		
Standard Memory (4 Ch / 2 Ch / 1 Ch) (Number of Segments)	16M / 32M /	' 32M (5,000)		/ 32M (5,000) 28M / 128M (15,000)
Acquisition Processing				
Averaging	Summed averaging to 1 milli		aging to 1 million sweeps	
Enhanced Resolution (ERES)	From 8.5- to 11-bits vertical			
Envelope (Extrema) Interpolation	Envelope, floor, or roof for up Linear or Sin x/x (2 pt and 5 pt			
Digital - Vertical and Acquisition	(-MS Models Only)			
Input Channels	16 Digital Channels			
Threshold Groupings	Pod 2: D15 - D8, Pod 1: D7 - D			
Threshold Selections	TTL, ECL, CMOS (2.5 V, 3.3 V,	, 5 V), PECL, LVDS or User De	fined	
Maximum Input Voltage	±30V Peak	00m\/)		
Threshold Accuracy Input Dynamic Range	\pm (3% of threshold setting + 1 \pm 20V	OUITIV)		
	V V			

	WaveRunner 8054	WaveRunner 8104	WaveRunner 8254/ 8254M	WaveRunner 8404/ 8404M
Digital - Vertical and Acquisition				
Input Impedance (Flying Leads)	100 kΩ 5 pF			
Maximum Input Frequency	250 MHz			
Sample Rate	1.25 GS/s	Ob a series of a	00040 16	01
Record Length		Channels	32MS - 16 M Models : 128M	
Minimum Detectable Pulse Width Channel-to-Channel Skew	2 ns 350 ps			
User Defined Threshold Range	±10 V in 20 mV steps			
User Defined Hysteresis Range	100 mV to 1.4 V in 100 mV ste	ps		
Triggering System				
Modes	Normal, Auto, Single, and Sto	p		
Sources		0, or line; slope and level unic	ue to each source (except line	e trigger)
Coupling Mode	DC, AC, HFRej, LFRej			
Pre-trigger Delay	0 - 100% of memory size (ad			
Post-trigger Delay			me/div settings or in roll mode	9
Hold-off by Time or Events	From 2 ns up to 20 s or from	I to 99,999,999 events		
Internal Trigger Range	±4.1 div from center (typical)	0.45.0 1.011-	0.45.0.05.015	0 15 0 4 01 1-
Trigger Sensitivity with Edge Trigger (Ch 1–4)	2 div @ < 500 MHz 1.5 div @ < 250 MHz	2 div @ < 1 GHz 1.5 div @ < 500 MHz	2 div @ < 2.5 GHz 1.5 div @ < 1.25 GHz	2 div @ < 4 GHz 1.5 div @ < 2 GHz
(OII 1 4)	1 div @ < 200 MHz	1.5 div @ < 200 MHz	1.5 div @ < 1.25 di iz	1 div @ < 200 MHz
	0.9 div @ < 10 MHz	0.9 div @ < 10 MHz	0.9 div @ < 10 MHz	0.9 div @ < 10 MHz
	(DC, AC, and	(DC, AC, and	(DC, AC, and	(DC, AC, and
- IT: 0 30 3	LFRej coupling)	LFRej coupling)	LFRej coupling)	LFRej coupling)
External Trigger Sensitivity, (Edge Trigger)	2 div @ 1 GHz 1.5 div @ < 500 MHz 1 div @ < 200 MHz			
	0.9 div @ < 10 MHz (DC, AC, and LFRej coupling)			
Max. Trigger Frequency,	500 MHz @ ≥	1.0 GHz @ ≥	2.0 GHz @ ≥	2.0 GHz @ ≥
SMART Trigger	10 mV/div 1.2 ns	10 mV/ďiv	10 mV/ďiv	10 mV/div
	(minimum triggerable	(minimum triggerable width 750 ps)	(minimum triggerable width 300 ps)	(minimum triggerable width 200 ps)
External Trigger Input Range	width 1.2 ns) Ext (±0.4 V); Ext/10 (±4 V)	width 750 ps)	widti1 300 ps)	width 200 ps)
External migger input hange	LXI (±0.4 V), LXI/ 10 (±4 V)			
Basic Triggers				
Edge	Triggers when signal meets s	slope (positive, negative, or ei	ther) and level condition	
Window	Triggers when signal exits a			
TV-Composite Video	Triggers NTSC or PAL with selectable line and field; HDTV (720p, 1080i, 1080p) with selectable frame rate (50 or 60 Hz) and Line; or CUSTOM with selectable Fields (1–8), Lines (up to 2000), Frame Rates (25, 30, 50, or 60 Hz), Interlacing (1:1, 2:1, 4:1, 8:1), or Synch Pulse Slope (Positive or Negative)			
SMART Triggers				
State or Edge Qualified	Triggers on any input source	only if a defined state or edg	e occurred on another input s	ource.
0 15 15	Delay between sources is sel			
Qualified First			nt B only if a defined pattern, s etween sources is selectable b	oy time or events
<u>Dropout</u> Pattern	Triggers if signal drops out for		between 1 ns and 20 s hannels and external trigger ir	anut Fach course can be
Pattern	high, low, or don't care. The F	ligh and Low level can be sel	ected independently. Triggers	at start or end of the pattern
SMART Triggers with Exclusion	Technology			
Glitch			table as low as 200 ps (deper	nding on oscilloscope band-
Width (Signal or Pattern)		ive glitches with widths selec	table as low as 500 ps (deper	nding on oscilloscope band-
Interval (Signal or Pattern)	Triggers on intervals selectal			
Timeout (State/Edge Qualified)			has occurred on another sou	rce
Runt	Delay between sources is 1 r	is to 20 s, or 1 to 99,999,999	events	
	Trigger on positive or negative Select between 1 ns and 20 n	าร		
Slew Rate			elect edge limits between 1 ns behavior and triggering when t	
Exclusion Triggering	mgger on intermittent faults	by specifying the expected t	benavior and inggering when t	nat condition is not met
Measurement Trigger	Trigger on measurement valu	ues, Edge, Serial Pattern. Bus	Pattern, Non-monotonic	
	JJ	, - 5-,	- ,	

	WaveRunner 8054	WaveRunner 8104	WaveRunner 8254/	WaveRunner 8404/	
Casada (Saguanas) Triggaring			8254M	8404M	
Cascade (Sequence) Triggering Capability	Arm on "A" event then Trigger	on "R" event Or Arm on "A"	event then Qualify on "R" even	t and Trigger on "C" event	
Types	Arm on "A" event, then Trigger on "B" event. Or Arm on "A" event, then Qualify on "B" event, and Trigger on "C" event. Cascade A then B: Edge, Window, Pattern (Logic) Width, Glitch, Interval, Dropout, or Measurement. Measurement can be on				
	Stage B only. Cascade A then B then C (Measurement): Edge, Window, Pattern (Logic), Width, Glitch, Interval, Dropout, or				
	Measurement. Measurement can be on Stage C only.				
	Cascade A then B then C: Edge	Window, Pattern (Logic).			
Holdoff			c), or Measurement. Measurem		
Floidoff		Holdoff between A and B, B and C, C and D is selectable by time (1ns to 20s) or number of events. Measurement trigger selection as the last stage in a Cascade precludes a holdoff setting between the			
	prior stage and the last stage			9	
Optional High-speed Serial Proto	ool Triggoring (WP9K-90P.	.0D10D TD)			
Data Rates	150 Mb/s=3.125 Gb/s	יטו מטומט)			
Pattern Length	80-bits, NRZ or 8b/10b			_	
Clock Recovery Jitter	1 ps _{rms} + 0.3% Unit Interval R	MS for PRBS data patterns v	with 50% transition density		
Hardware Clock Recovery Loop BW	PLL Loop BW = Fbaud/5500,				
Color Moveform Dienlay					
Color Waveform Display Type	Color 12.1" widescreen flat pa	upol TET Active Matrix with h	igh resolution touch serven		
Resolution	WXGA; 1280 x 800 pixels	iner it i-Active Matrix With I	ign resolution touch screen		
Number of Traces		ces. Simultaneously display	channel, zoom, memory and n	nath traces	
Grid Styles			andem, Quatro, Twelve, Sixtee		
Waveform Representation	Sample dots joined, or sample				
Processor/CPU					
Type	Intel® i5-3610 Dual Core, 2.7	CHz (or hetter)			
Processor Memory	8 GB standard, up to 16 GB of				
. recesses memory	M Models: 16 GB standard	Stroman			
Operating System	Microsoft Windows® 7 Profes				
Real Time Clock	Date and time displayed with	waveform in hardcopy files. S	SNTP support to synchronize to	precision internal clocks	
Interface					
Remote Control	Via Windows Automation, or	via Teledyne I eCrov Remote	Command Set		
Network Communication Standard	VXI-11 or VICP, LXI Class C (v		Ostriiriana occ	 -	
GPIB Port (Optional)	Supports IEEE-488.2 (Extern				
Ethernet Port	Supports 10/100/1000Base-		ort)		
USB			nt USB 2.0 port support Windo	ows compatible devices	
USB Device Port	1 port - USBTMC over USB 3.				
External Monitor Port	2 full-size Display Port connection	ctors and 1 DVI-D. I desktop operation with WX	GA resolution on second mon	itor	
	includes support for extended	a desirtop operation with wix	OA resolution on second mon	1101	
Power Requirements					
Voltage	100-240 VAC ±10% at 50/60 Automatic AC Voltage Selecti	Hz ±5%; 100–120 VAC ±10°	% at 400 Hz ±5%;		
Power Consumption (Nominal)	285 W / 285 VA, M Models : 4		OVOALII		
Max Power Consumption	375 W / 375 VA, M Models : 5				
·	with all PC peripherals, active	probes connected to 4 char	inels, and MSO active		
Environmental					
Temperature (Operating)	+5 °C to +40 °C				
Temperature (Non-Operating)	-20 °C to +60 °C				
Humidity (Operating)	5% to 90% relative humidity (r	non-condensing) up to +31 °	C		
	Upper limit derates to 50% re	ative humidity (Non-conden	sing) at +40 °C		
Humidity (Non-Operating)	5% to 95% relative humidity (r		er MIL-PRF-28800F		
Altitude (Operating)	Up to 3,000 m at or below +3				
Random Vibration (Operating)	0.31 g _{rms} 5 Hz to 500 Hz, 15 m 2.4 g _{rms} 5 Hz to 500 Hz, 15 m	ninutes in each of three orth	ogonal axes		
Random Vibration (Non-Operating) Functional Shock			gonal axes e) in each of three orthogonal axe	s 18 shocks total	
i dilotional officer	оо уреак, пап этге, тттть ригье,	o onoono (positive alla negativi	on the capital axe	, 10 3110013 10101	
Physical Dimensions					
Dimensions (HWD)	12.44" H x 16.42" W x 9.37" D	(316 x 417 x 238 mm)			
Weight	22.8 lbs. (10.3 kg)				
Certifications					
	CE Compliant, UL and cUL lis	ted; Conforms to UL 61010-) (1st Edition)	
	CAN/CSA C22.2 No. 61010-1-		,, , , , , , , , , , , , , , , , , , , ,	,	
Warranty and Service					
	3-year warranty; calibration re	ecommended annually. Optic	onal service programs include	extended warranty,	
	upgrades, and calibration ser	VICES			

Standard

Math Tools

Display up to 8 math function traces (F1-F8). The easy-to-use graphical interface simplifies setup of up to two operations on each function trace, and function traces can be chained together to perform math-on-math.

exp (base 10) absolute value product (x) fft (power spectrum, average (summed) reciprocal power average, average (continuous) rescale (with units) magnitude, phase, correlation roof up to 128 Mpts) (two waveforms) (sinx)/x floor derivative sparse integral deskew (resample) square interpolate (cubic, difference (-) square root quadratic, sinx/x) enhanced resolution sum (+) invert (negate) (to 11 bits vertical) log (base e) zoom (identity) envelope log (base 10) exp (base e)

Measure Tools

Display any 8 parameters together with statistics, including their average, high, low, and standard deviations. Histicons provide a fast, dynamic view of parameters and wave shape characteristics. Parameter Math allows addition, subtraction, multiplication, or division of two different parameters.

amplitude level @ x rms area maximum std. deviation mean base top bit rate median width minimum phase cycles delay narrow band phase time @ minimum (min.) time @ maximum (max.) ∆ delay narrow band power duty cycle number of points ∆ time @ level duration + overshoot △ time @ level from trigger falltime (90-10%, - overshoot 80-20%, @ level) x @ max. peak-to-peak frequency x@min. period first risetime (10-90%, 20-80%, @ level) last

Pass/Fail Testing

Simultaneously test multiple parameters against selectable parameter limits or pre-defined masks. Pass or fail conditions can initiate actions including document to local or networked files, e-mail the image of the failure, save waveforms, send a pulse out at the front panel auxiliary BNC output, or (with the GPIB option) send a GPIB SRQ.

Standard (cont'd)

Basic Jitter and Timing Analysis

This package provides jitter timing and analysis using time, frequency, and statistical views for common timing parameters, and also includes other useful tools. Includes:

- "Track" graphs of all parameters, no limitation of number
- N-Cycle Width @ level Skew
 Edge to Edge Time Interval Duty Cycle @ level
 Frequency @ level Setup
 Half Period Width @ level Duty Cycle @ level
 Duty Cycle Error
 Duty Cycle Error
 Hold
- Edge @ Iv parameter (counts edges)
- Histograms expanded with 19 histogram parameters and up to 2 billion events
- Trend (datalog) of up to 1 million events
- Persistence histogram, persistence trace (mean, range, sigma)

Software Options

Advanced Customization (WR8K-XDEV)

Provides capability to create a math function or measurement parameter in MATLAB, Excel, C++, JavaScript, or Visual Basic Script (VBS) format and insert it into the oscilloscope's processing stream. All results are processed and displayed on the oscilloscope grid, and are available for further processing. Also permits the creation of customized plug-ins that can be inserted into the scope user interface, control of the scope via Visual Basic scripts embedded in customized functions, and use of Teledyne LeCroy's Custom DSO capabilities.

SDA II Serial Data Analysis Option (WR8K-SDAII)

Total Jitter

A complete toolset is provided to measure total jitter. Eye Diagrams with millions of UI are quickly calculated from up to 128 Mpts records, and advanced tools may be used on the Eye Diagram to aid analysis. Complete TIE and Total Jitter (Tj) parameters and analysis functions are provided.

- Time Interval Error (TIE) Measurement Parameter, Histogram, Spectrum and Jitter Track
- Total Jitter (Tj) Measurement Parameter, Histogram, Spectrum
- Eye Diagram Display (sliced)
- Eye Diagram IsoBER (lines of constant Bit Error Rate)
- · Eye Diagram Mask Violation Locator
- Eye Diagram Measurement Parameters

Eye Height
 Dne Level
 Eye Crossing
 Mask out
 Zero Level
 Eye Power
 Eye Amplitude
 Extinction Ratio
 Slice Width (setting)

- Q-Fit Tail Representation
- Bathtub Curve
- · Cumulative Density Function (CDF)
- PLL Track

Software Options (cont'd)

SDA II Serial Data Analysis Option (WR8K-SDAII) - continued

Jitter Decomposition Models

Two jitter decomposition methods are provided and simultaneously calculated to provide maximum measurement confidence. Q-Scale, CDF, Bathtub Curve, and all jitter decomposition measurement parameters can be displayed using either method.

- Spectral Method
- NQ-Scale Method

Random Jitter (Rj) and Non-Data Dependent Jitter (Rj+BUj)

- Random Jitter (Rj) Measurement Parameter
- Rj+BUj Histogram
- Rj+BUj Spectrum
- Rj+BUj Track

Deterministic Jitter (Dj)

• Deterministic Jitter (Dj) Measurement Parameter

Data Dependent Jitter (DDi)

- Data Dependent Jitter (DDj) Measurement Parameter
- DDi Histogram
- DDj Plot (by Pattern or N-bit Sequence)

Eye Doctor II Advanced Signal Integrity Tools (WR8K-EYEDRII)

Complete set of channel emulation, de-embedding and receiver equalization simulation tools. Provides capability to emulate a serial data link, de-embed or embed a fixture, cable or serial data channel, add or remove emphasis, and perform CTLE, FFE, or DFE equalization.

Power Analyzer Option (WR8K-PWR)

Power switching device measurements, control loop modulation analysis, and line power harmonic testing are all simplified with a dedicated user interface and automatic measurements.

Device Analysis

- Losses Automatic measurement of turn-on, turn-off, and conduction loses as well as off-state power, total losses and switching frequency
- Safe Operating Area
- B-H-Hysteresis Curve
- Dynamic On-Resistance
- Dv/dt and di/vt

Control Loop Analysis

Closed loop time-domain – Duty cycle, width, period or frequency

Line Power Analysis

- Power Vrms, Irms, real-power, apparent power, power factor, crest factor
- Harmonics EN61000-3-2 pre-compliance, Total Harmonic Distortion

Measurement Setup

Controls for Deskew, DC fine adjust, probe integration, device zone identification

Cable De-embedding Option (WR8K-CBL-DE-EMBED)

Removes cable effects from your measurements. Simply enter the S-parameters or attenuation data of the cable(s) then all of the functionality of the WR8K can be utilized with cable effects de-embedded.

8b/10b Decode and 80-bit High Speed Serial Trigger Option (WR8K-80B-8B10B TD)

Intuitive, color-coded serial trigger decode with powerful search capability enables captured waveforms to be searched for user-defined sequences of symbols. Multi-lane analysis decodes up to four simultaneously captured lanes. Includes 150 Mb/s to 3.125 Gb/s High-speed 80-bit Serial Pattern Trigger Option

Software Options (cont'd)

Serial Data Mask Option (WR8K-SDM)

Create eye diagrams using a comprehensive list of standard eye pattern masks, or create a user-defined mask. Mask violations are clearly marked on the display for easy analysis.

Electrical Telecom Pulse Mask Test Option (WR8K-ET-PMT)

Performs automated compliance mask tests on a wide range of electrical telecom standards.

Spectrum Analyzer Option (WR8K-SPECTRUM)

Spectrum analyzer style user interface and advanced FFT capabilities.

- Automatic oscilloscope setup when selecting start/stop frequency or center frequency and span
- · Resolution bandwidth automatically or manually controlled
- FFT Reference and vertical scale in dBm, dBV, dBmV, dBuV, Vrms or Arms
- Spectrogram provides 2D or 3D spectral history display
- Up to 100 automatic peak markers
- Up to 20 markers, either manually controlled or automatic which mark fundamental frequency and harmonics
- Math waveform analysis, additional output types:
- Power density
- Real
- Imaginary
- Magnitude squared

Disk Drive Measurements Option (WR8K-DDM2)

This package provides disk drive parameter measurements and related mathematical functions for performing disk drive WaveShape Analysis.

- Disk Drive Parameters are as follows:
- amplitude asymetry
- local base
- local baseline separation
- local maximum
- local minimum
- la a al la cua la au
- local number
- local peak-peaklocal time
- between events
- local time between peaks
- local time
 between troughs

- local time at minimum
- local time
 at maximum
- local time peak-trough
- local time
- over threshold

 local time
- trough-peak
 local time
- under threshold
- narrow band phase
- narrow band power

- overwrite
- pulse width 50
- pulse width 50 -
- pulse width 50 +
- resolution
- track average amplitude
- track average amplitude –
- track average amplitude +
- auto-correlation s/n
- non-linear transition shift

ORDERING INFORMATION

Product Description	Product Code
WaveRunner 8000 Oscilloscopes	
500 MHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8054
Oscilloscope with 12.1"" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
1 GHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8104
Oscilloscope with 12.1"" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
2.5 GHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8254
Oscilloscope with 12.1"" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
4 GHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8404
Oscilloscope with 12.1" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
2.5 GHz, 20 GS/s, 4ch, 64 Mpts/Ch	WaveRunner 8254M
Oscilloscope with 12.1" WXGA Color Display.	
128 Mpts/Ch in interleaved mode.	
4 GHz, 20 GS/s, 4ch, 64 Mpts/Ch	WaveRunner 8404M
Oscilloscope with 12.1" WXGA Color Display.	
128 Mpts/Ch in interleaved mode.	
500 MHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8054-MS
Mixed Signal Oscilloscope with	
12.1" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
1 GHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8104-MS
Mixed Signal Oscilloscope with	
12.1" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
2.5 GHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8254-MS
Mixed Signal Oscilloscope with	
12.1" WXGA Color Display.	
32 Mpts/Ch in interleaved mode	
4 GHz, 10 GS/s, 4ch, 16 Mpts/Ch Mixed	WaveRunner 8404-MS
Signal Oscilloscope with	
12.1" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
2.5 GHz, 20 GS/s, 4ch, 64 Mpts/Ch	WaveRunner 8254M-MS
Mixed Signal Oscilloscope with	
12.1" WXGA Color Display.	
128 Mpts/Ch in interleaved mode.	
4 GHz, 20 GS/s, 4ch, 64 Mpts/Ch	WaveRunner 8404M-MS
Mixed Signal Oscilloscope with	
12.1" WXGA Color Display.	
128 Mpts/Ch in interleaved mode.	
pto, o interred to a mode.	

Included with Standard Configurations (WaveRunner 8000 and WaveRunner 8000-MS)

÷10, 500 MHz Passive Probe (Qty. 4), Protective Cover, Getting Started Guide, Anti-virus Software (Trial Version), Microsoft Windows® 7 for Embedded Systems 64-bit License, Commercial NIST Traceable Calibration with Certificate, Power Cable for the Destination Country, 3-year Warranty

Included with WaveRunner 8000-MS

16 Channel Digital Leadset, Extra Large Gripper Probe Set (Qty. 22), Ground Extenders (Qty. 20), Flexible Ground Leads (Qty. 5)

Computer Upgrade

Compater Opgrade	
256 GB Removable Solid State Drive Option	WR8K-256GB-RSSD
Additional 256 GB Solid State Drive for use	WR8K-256GB-RSD-02
with RSSD option. Includes Windows 7 Pro for	
Embedded Systems OS, LeCroy Oscilloscope	
Software and Critical Scope Operational	
File Duplicates.	
Upgrade from 8 GB RAM to 16 GB RAM	WR8K-UPG-16GBRAM

Product Description	Product Code
---------------------	--------------

Product Description	Product Code
Serial Trigger and Decode	WP9//1559.TP
MIL-STD-1553 Trigger and Decode Option	
MIL-STD-1553 Trigger, Decode, Measure Graph, and Eye Diagram Option	e/ WR8K-1553 TDME
8b10b Decode Option- Includes 80 bit	WR8K-80B-8b10b TD
3.125 Gb/s serial trigger AudioBus Trigger and Decode Option	WR8K-Audiobus TD
AudioBus trigger, decode, and graph Opt	
	8K-ARINC429BUS DSYMBOLIC
Decode Option	BICALLING 429BOS DSTIMBOLIC
	ARINC429BUS DME SYMBOLIC
Decode, Measure/Graph,	
and Eye Diagram Option CAN FD Trigger and Decode Option	WR8K-CAN FDBUS TD
CAN FD Trigger and Decode Option CAN FD Trigger, Decode, Measure/	WR8K-CAN FDBUS TDME
Graph, and Eye Diagram Option	WHOR CART DDGG TDINE
	-CAN FDBUS TDME SYMBOLIC
Decode, and Measure/Graph,	
and Eye Diagram Option	
CAN Trigger & Decode Option	WR8K-CANBUS TD
CAN Trigger, Decode, Measure/Graph,	WR8K-CANBUS TDME
and Eye Diagram Option	OOK CANDI IS TOME OVA 4DOLLO
CAN Symbolic Trigger, WF Decode, and Measure/Graph,	88K-CANBUS TDME SYMBOLIC
and Eye Diagram Option	
DigRF 3G Bus Decode Option	WR8K-DigRF3Gbus D
DigRF V4 Bus Decode Option	WR8K-DigRFV4bus D
MIPI D-PHY CSI-2, DSI Bus Decode Option	on WR8K-DPHYbus D
MIPI D-PHY CSI-2, DSI Bus Decode and	WR8K-DPHYbus DP
Physical Layer Test Option	
ENET Bus Decode Option	WR8K-ENETbus D
Bundle: Includes I2C, SPI, UART-RS232	WR8K-EMB TD
Trigger and Decode Option	11/201/ 51 12 721 15
Bundle: Incl. I2C, SPI, UART-RS232	WR8K-EMB TDME
Trigger, Decode, Measure/Graph, and Eye Diagram Option	
FibreChannel decode annotation Option	WR8K-FCbus D
FlexRay Trigger and Decode Option	WR8K-FLEXRAYBUS TD
FlexRay Trigger, Decode, Measure/	WR8K-FLEXRAYBUS TDMP
Graph and Physical Layer Option	
I2C Trigger and Decode Option	WR8K-I2CBUS TD
I2C Trigger, Decode, Measure/Graph,	WR8K-I2CBUS TDME
and Eye Diagram Option	
LIN Trigger and Decode Option	WR8K-LINBUS TD
LIN Trigger, Decode, Measure/Graph,	WR8K-LINBUS TDME
and Eye Diagram Option Manchester Bus Decode Option	WR8K-MANCHESTERbus D
MIPI M-PHY Bus Decode Option	WR8K-MPHYbus D
MIPI M-PHY Bus Decode and Physical	WR8K-MPHYbus DP
Layer Test Option	WHOR WILLIAMS DI
NRZ Bus Decode Option	WR8K-NRZbus D
PCIe Gen 1 Decode Option	WR8K-PClebus D
Serial Debug Toolkit - Measure Analyze	WR8K-PROTOBUS MAG
Graph Option	
Decode Annotation and Protocol	WR8K-ProtoSync
Analyzer Synchronization Option	D'I MENTE LO DE
Decode Annotation and Protocol Analyz	er+Bit WR8K-ProtoSync-BT
Tracer Synchronization Option	WR8K-SASbus D
SAS Decode annotation Option SATA Trigger and Decode Option	WR8K-SATAbus TD
SENT Bus Decode Option	WR8K-SENTbus D
SpaceWire Decode Option	WR8K-SPACEWIREbus D
SPI Trigger and Decode Option	WR8K-SPIBUS TD
SPI Trigger, Decode, Measure/Graph,	WR8K-SPIBUS TDME
and Eye Diagram Option	o.c.o. iboo ibiwe
UART-RS232 Trigger and Decode Option	WR8K-UART-RS232BUS TD
UART-RS232 Trigger, Decode,	WR8K-UART-RS232BUS TDME
Measure/Graph, and Eye Diagram Option	

ORDERING INFORMATION

Product Description	Product Code	Product Description	Product Code
Serial Trigger and Decode		General Accessories	
MIPI UniPro Protocol Decoder Software Optio	n WR8K-LINIPROhus D	Oscilloscope Cart with Additional Shelf and Drawer	OC1024
•	IPG-MPHY-UNIPRObus D	Oscilloscope Cart	OC1021
Software Upgrade		Rackmount, 8U Adaptor Kit	WR8K-RACK
MPHY REQUIRED		Keyboard, USB	KYBD-1
USB 2.0 HSIC Decode Option	WR8K-USB2-HSICbus D	Soft Carrying Case	WR8K-SOFTCASE
USB2 Trigger and Decode Option	WR8K-USB2bus TD		
USB 2.0 Trigger and Decode Option	WR8K-USB2BUS TD	Probes	
USB 2.0 Trigger, Decode, Measure/	WR8K-USB2BUS TDME	500 MHz Passive Probe, 2.5mm, 10:1, 10 MΩ	PP022
Graph, and Eye Diagram Option		500 MHz Passive Probe, 5mm, 10:1, 10 M Ω	PP024
		1 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe	ZS1000
Serial Data Compliance		Set of 4 ZS1000, 1 GHz, 0.9 pF,	ZS1000-QUADPAK
QualiPHY Enabled BroadR-Reach	QPHY-BroadR-Reach	1 MΩ High Impedance Active Probe	
Software Option		1.5 GHz, 0.9 pF, 1 M Ω High Impedance Active Probe	
QualiPHY Enabled Ethernet 10/100/1000BT	QPHY-ENET*	Set of 4 ZS1500, 1.5 GHz, 0.9 pF,	ZS1500-QUADPAK
Software Option	00111/0000	1 MΩ High Impedance Active Probe	700500
QualiPHY Enabled DDR2 Software Option	QPHY-DDR2	2.5 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe	
QualiPHY Enabled DDR3 Software Option	QPHY-DDR3	Set of 4 ZS2500, 2.5 GHz, 0.9 pF, 1 M Ω High Impedance Active Probe	ZS2500-QUADPAK
QualiPHY Enabled LPDDR2 Software Option	QPHY-LPDDR2	4 GHz, 0.6 pF, 1 MΩ High Impedance Active Probe	ZS4000
QualiPHY Enabled MIPI D-PHY Software Option		200 MHz, 3.5 pF, 1 M Ω Active Differential Probe, ±2	
QualiPHY Enabled MOST150Software Option	QPHY-MOST150	500 MHz, 1.0 pF Active Differential Probe, ±8 V	ZD500
QualiPHY Enabled MOST50 Software Option	QPHY-MOST50 QPHY-USB‡	1 GHz, 1.0 pF Active Differential Probe, ±8 V	ZD1000
QualiPHY Enabled USB 2.0 Software Option	TF-ENET-B**	1.5 GHz, 1.0 pF Active Differential Probe, ±8 V	ZD1500
10/100/1000Base-T Ethernet Test Fixture USB 2.0 Compliance Test Fixture	TF-ENET-B	WaveLink 4 GHz, 2.5 Vp-p Differential Probe System	D410-PS
* TF-ENET-B required.	1F-USB-B	WaveLink 4 GHz, 5 Vp-p Differential Probe System	D420-PS
** Includes ENET-2CAB-SMA018 and ENET-2ADA-BI	ICSMA	WaveLink 6 GHz, 2.5 Vp-p Differential Probe System	D610-PS
Includes ENET ZOAD OMACTO and ENET ZADA DI	VOOIVIA.	WaveLink 6 GHz, 5 Vp-p Differential Probe System	D620-PS
Serial Data Analysis		WaveLink 4 GHz Differential Amplifier Module	D400A-AT*
Cable De-Embedding Option	WR8K-CBL-DE-EMBED	with Adjustable Tip	
Eye Doctor (Virtual Probe and Equalizer	WROK-CBL-DE-EIVIBED WR8K-EYEDRII	WaveLink 6 GHz Differential Amplifier Module	D600A-AT*
Emulation Bundle)	WHOKETEDIII	with Adjustable Tip	
Serial Data Mask Software Option	WR8K-SDM	WaveLink ProBus Platform/Cable Assembly (4 GHz)	
SDAII Serial Data Analysis Option	WR8K-SDAII	1 Ch, 100 MHz Differential Amplifier with Precision Voltage Source	DA1855A
OD/ III Octivi Data / Iliaiyolo Option	WHOR GEATH	DA1855A with Rackmount	DA1855A-RM
DDR Debug Toolkits		2 Ch, 100 MHz Differential Amplifier	DA1855A-PR2
DDR2 and LPDDR2 Debug Toolkit	WR8K-DDR2-TOOLKIT	with Precision Voltage Source	DATOSSATTIZ
DDR3, DDR3L, LPDDR3, DDR2, and	WR8K-DDR3-TOOLKIT	DA1855A with Rackmount (must be ordered at	DA1855A-PR2-RM
LPDDR2 Debug Toolkit	WHORE BOTTO TO CENT	time of purchase, no retrofit)	
	R8K-UPG-DDR3-TOOLKIT	30 A; 50 MHz Current Probe – AC/DC; 30 Arms;	AP015
LPDDR2 Debug Toolkit Upgrade		50 Apeak Pulse	
Er BBrie Bosag roomit opgrade		30 A; 50 MHz Current Probe – AC/DC; 30 Arms;	CP030
Data Storage Software		50 Apeak Pulse	
Advanced Optical Recording Measurement Pa	ackage WR8K-AORM	30A, 50 MHz High Sensitivity Current Probe -	CP030A
Disk Drive Measurements Software Package	WR8K-DDM2	AC/DC, 30 A rms, 50 A Peak Pulse, 1.5 meter cable 30 A; 100 MHz Current Probe – AC/DC; 30 Arms;	00001
Disk Drive Analyzer Software Package	WR8K-DDA	50 Apeak Pulse	CP031
- · · · · · · · · · · · · · · · · · · ·		30A, 100 MHz High Sensitivity Current Probe -	CP031A
Power Analysis Software		AC/DC, 30 A rms, 50 A Peak Pulse, 1.5 meter cable	CPUSTA
Power Analyzer Software Option	WR8K-PWR	150 A; 10 MHz Current Probe – AC/DC;	CP150
1 ower / maryzer continues option	WHOILT WIT	150 Arms; 500 Apeak Pulse	000
Jitter Analysis Software		500 A; 2 MHz Current Probe - AC/DC;	CP500
Clock, Clock-Data Jitter Analysis And Views O	f Time, WR8K-JITKIT	500 Arms; 700 Apeak Pulse	
Statistical, Spectral, and Jitter Overlay	i ilile, Witole 3111(11	Programmable Current Sensor to ProBus Adapter fo	r CA10
Statistical, Spectral, and Sitter Overlay		use with third party current sensors	
Other Software Options		Set of 4 CA10 Programmable Current Sensor to	CA10-QUADPAK
Advanced Customization Option	WR8K-XDEV	ProBus Adapters for third-party current sensors	100)
EMC Pulse Parameter Software Option	WR8K-EMC	700 V, 15 MHz High-Voltage Differential Probe (÷10	
Electrical Telecom Mask Test Software Option		100:1 400 MHz 50 MΩ 1 kV High-voltage Probe	HVP120
Q-Scape Multi-tab Display Option	WR8K-Q-SCAPE	10:1/100:1 200/300 MHz 50 MΩ High-Voltage Prot 600 V/1.2 kV Max. Volt. DC	pe PPE1.2KV
Spectrum Analyzer and Advanced FFT Option		100:1 400 MHz 50 MΩ 2 kV High-Voltage Probe	PPE2KV
Spectrum Analyzer and Advanced FFT Option	WHOIN-OFEUI NUIVI	100:1 400 MHz 50 M Ω 4 kV High-Voltage Probe	PPE4KV
Digital Filtoring Coffware		1000:1 400 MHz 50 M Ω 5 kV High-Voltage Probe	PPE5KV
Digital Filtering Software Digital Filter Software Option	WR8K-DFP2	1000:1 400 MHz 5 M Ω / 50 M Ω 6 kV High-Voltage P	
Digital Filler Software Option	WNON-UFFZ	* For a complete probe, order a WL-PBUS-CASE Plat	
Remote Control/Network Options		Assembly with the Adjustable Tip Module	IOITI/ Cable
External USB2 to GPIB Adaptor	USB2-GPIB	, , , , , , , , , , , , , , , , , , , ,	
Ελιστίαι 0002 το στιο Αυαμτοί	0302-0710		

ORDERING INFORMATION

Product Description

Product Code

Pro	hes i	(cont	d)

Flobes (colled)	
TekProbe to ProBus Probe Adapter	TPA10
Set of 4 TPA10 TekProbe to ProBus Probe Adapters. Includes soft carrying case	TPA10-QUADPAK
Optical-to-Electrical Converter, 500-870 nm ProBus	OE425
BNC Connector	
Optical-to-Electrical Converter, 950-1630 nm ProBus	OE455
BNC Connector	
1kV, 25 MHz High Voltage Differential Probe	HVD3102
1kV, 25 MHz High Voltage Differential	HVD3102-NOACC
Probe without tip Accessories	
1kV, 120 MHz High Voltage Differential Probe	HVD3106
1kV, 120 MHz High Voltage Differential	HVD3106-NOACC
Probe without tip Accessories	
2kV, 120 MHz High Voltage Differential Probe	HVD3206
2kV, 80 MHz High Voltage Differential Probe	HVD3206-6M
with 6m cable	
6kV, 100 MHz High Voltage Differential Probe	HVD3605



1-800-5-LeCroy teledynelecroy.com

Local sales offices are located throughout the world. Visit our website to find the most convenient location.

© 2016 by Teledyne LeCroy, Inc. All rights reserved. Specifications, prices, availability, and delivery subject to change without notice. Product or brand names are trademarks or requested trademarks of their respective holders.

PCI Express® is a registered trademark and/or service mark of PCI-SIG.